



STP30NS15LFP

N-channel 150V - 0.085Ω - 10A - TO-220FP
MESH OVERLAY™ II Power MOSFET

General features

| Type | V _{DSS} | R _{DS(on)} | I _D |
|--------------|------------------|---------------------|----------------|
| STP30NS15LFP | 150V | <0.1Ω | 10A |

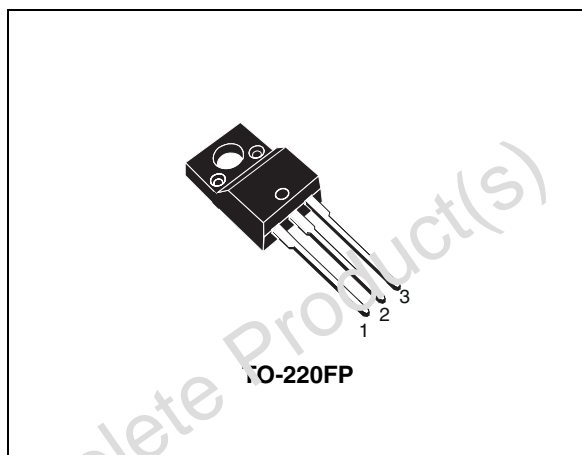
- Extremely high dv/dt capability
- Application oriented characterization
- 100% avalanche tested

Description

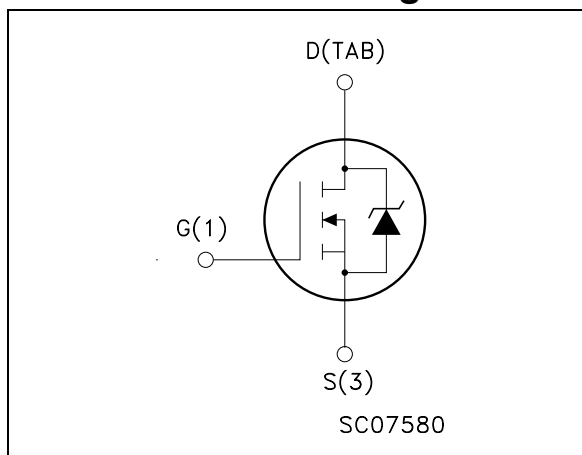
Using the latest high voltage MESH OVERLAY™ process, STMicroelectronics has designed an advanced family of power MOSFETs with outstanding performances. The new patent pending strip layout coupled with the Company's proprietary edge termination structure, gives the lowest RDS(on) per area, exceptional avalanche and dv/dt capabilities and unrivalled gate charge and switching characteristics.

Applications

- Switching application



Internal schematic diagram



Order codes

| Part number | Marking | Package | Packaging |
|--------------|-------------|----------|-----------|
| STP30NS15LFP | P30NS15LFP@ | TO-220FP | Tube |

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Obsolete Product(s) - Obsolete Product(s)

1 Electrical ratings

Table 1. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|----------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage ($V_{GS} = 0$) | 150 | V |
| V_{GS} | Gate- source voltage | ± 15 | V |
| I_D | Drain current (continuous) at $T_C = 25^\circ\text{C}$ | 10 | A |
| $I_D^{(1)}$ | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 7 | A |
| $I_{DM}^{(1)}$ | Drain current (pulsed) | 40 | A |
| P_{tot} | Total dissipation at $T_C = 25^\circ\text{C}$ | 30 | W |
| | Derating factor | 0.2 | W/ $^\circ\text{C}$ |
| $E_{AS}^{(2)}$ | Single pulse avalanche energy | 300 | mJ |
| $dv/dt^{(3)}$ | Peak diode recovery voltage slope | 2.4 | V/ns |
| V_{ISO} | Insulation withstand voltage (RMS) from all three leads to external heat sink ($t = 1\text{ s}$; $T_C = 25^\circ\text{C}$) | 2500 | V |
| T_{stg} | Storage temperature | -55 to 175 | $^\circ\text{C}$ |
| T_j | Max. operating junction temperature | | |

1. Pulse width limited by safe operating area.
2. Starting $T_j = 25^\circ\text{C}$, $I_D = 15\text{ A}$, $V_{GS} = 15\text{ V}$
3. $I_{SD} \leq 35\text{ A}$, $di/dt \leq 300\text{ A}/\mu\text{s}$, $v_{DD} \leq V_{(BR)DSS}$, $T_j \leq T_{JMAX}$

Table 2. Thermal data

| | | | |
|-----------------------|--|------|---------------------------|
| $R_{thj\text{-case}}$ | Thermal resistance junction-case max | 5 | $^\circ\text{C}/\text{W}$ |
| $R_{thj\text{-amb}}$ | Thermal resistance junction-ambient max | 62.5 | $^\circ\text{C}/\text{W}$ |
| T_J | Maximum lead temperature for soldering purpose | 300 | $^\circ\text{C}$ |

2 Electrical characteristics

($T_{CASE}=25^{\circ}C$ unless otherwise specified)

Table 3. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|-------------|--------------|----------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250\mu A, V_{GS} = 0$ | 150 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = \text{max ratings}$ $V_{DS} = \text{max ratings},$ $T_C = 125^{\circ}C$ | | | 1 10 | μA μA |
| I_{GSS} | Gate-body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 15V$ | | | ± 100 | nA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 1 | 2 | 3 | V |
| $R_{DS(on)}$ | Static drain-source on resistance | $V_{GS} = 10V, I_D = 5A$ $V_{GS} = 5V, I_D = 5A$ | | 0.85 0.1 | 0.1 0.112 | Ω Ω |

Table 4. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|----------------|------------------------------|--|------|------|------|------|
| $g_{fs}^{(1)}$ | Forward transconductance | $V_{DS} = 20V, I_D = 7A$ | | 6 | | S |
| C_{iss} | Input capacitance | $V_{DS} = 25V, f = 1MHz,$ $V_{GS} = 0$ | | 1080 | | pF |
| C_{oss} | Output capacitance | | | 170 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 105 | | pF |
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 15V, I_D = 5A$ $R_G = 4.7\Omega, V_{GS} = 4.5V$ (see Figure 13) | | 25 | | ns |
| t_r | Rise time | | | 95 | | ns |
| $t_{d(off)}$ | Turn-off delay time | | | 55 | | ns |
| t_f | Fall time | | | 30 | | ns |
| Q_g | Total gate charge | $V_{DD} = 120V, I_D = 10A,$ $V_{GS} = 5V$ (see Figure 14) | | 40 | 54 | nC |
| Q_{gs} | Gate-source charge | | | 7.5 | | nC |
| Q_{gd} | Gate-drain charge | | | 20 | | nC |

1. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %.

Table 5. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|---|------|------------------|----------|---------------|
| I_{SD} $I_{SDM}^{(1)}$ | Source-drain current Source-drain current (pulsed) | | | | 10 40 | A A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD} = 10A, V_{GS} = 0$ | | | 1.3 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD} = 10A,$ $di/dt = 100A/\mu s,$ $V_{DD} = 30V, T_j = 150^\circ C$ (see Figure 15) | | 160 950 12 | | ns nC A |

1. Pulse width limited by safe operating area.
2. Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

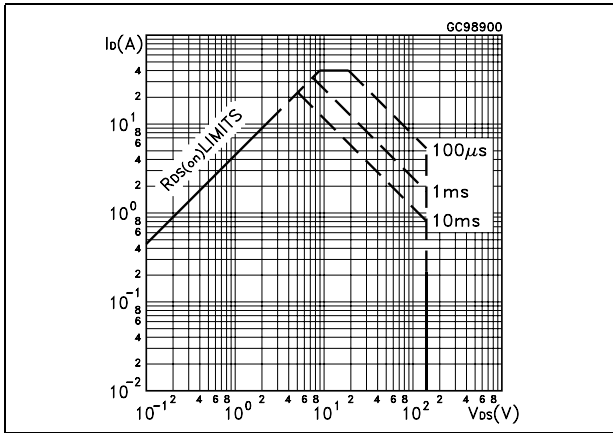


Figure 2. Thermal impedance

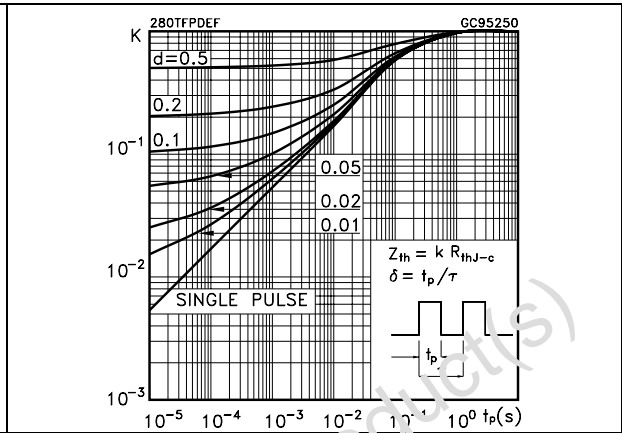


Figure 3. Output characteristics

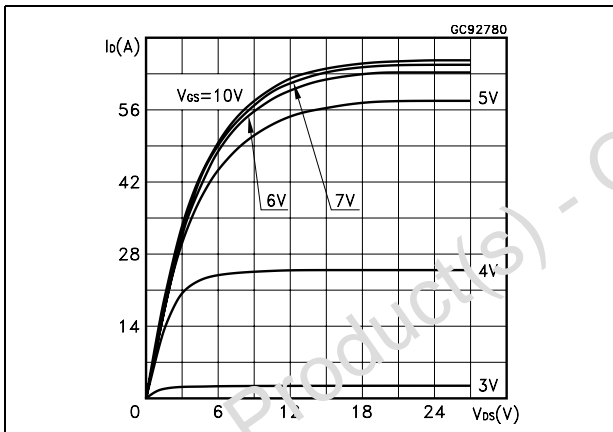


Figure 4. Transfer characteristics

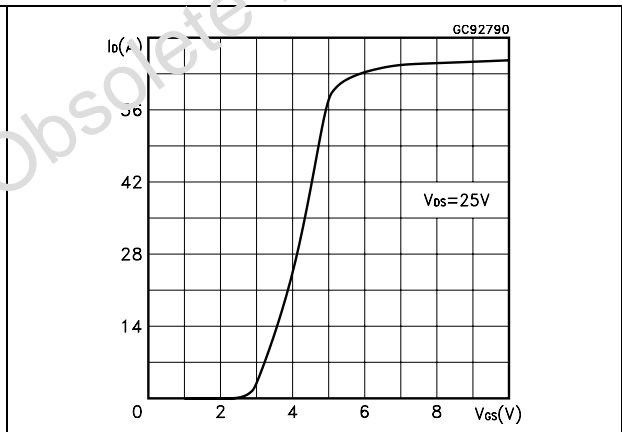


Figure 5. Transconductance

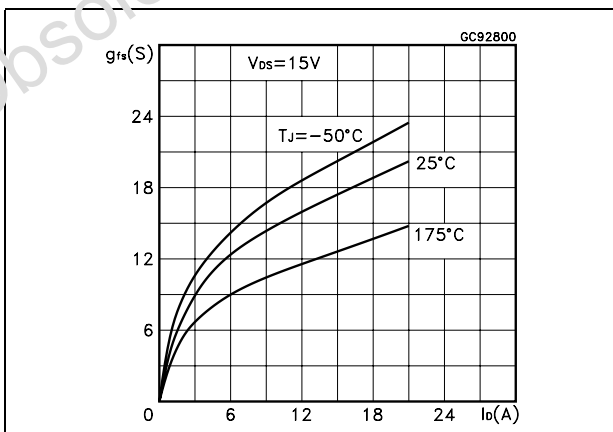


Figure 6. Static drain-source on resistance

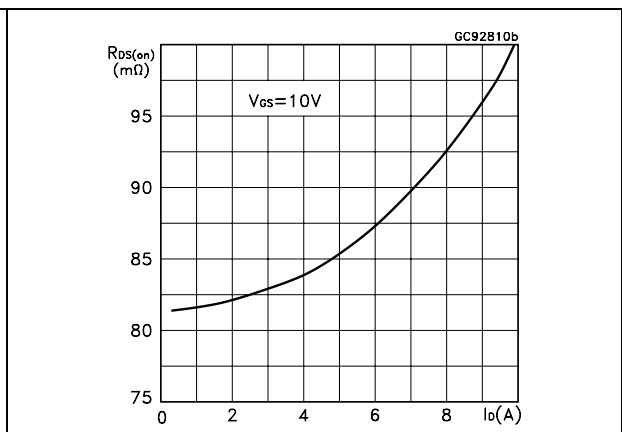


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

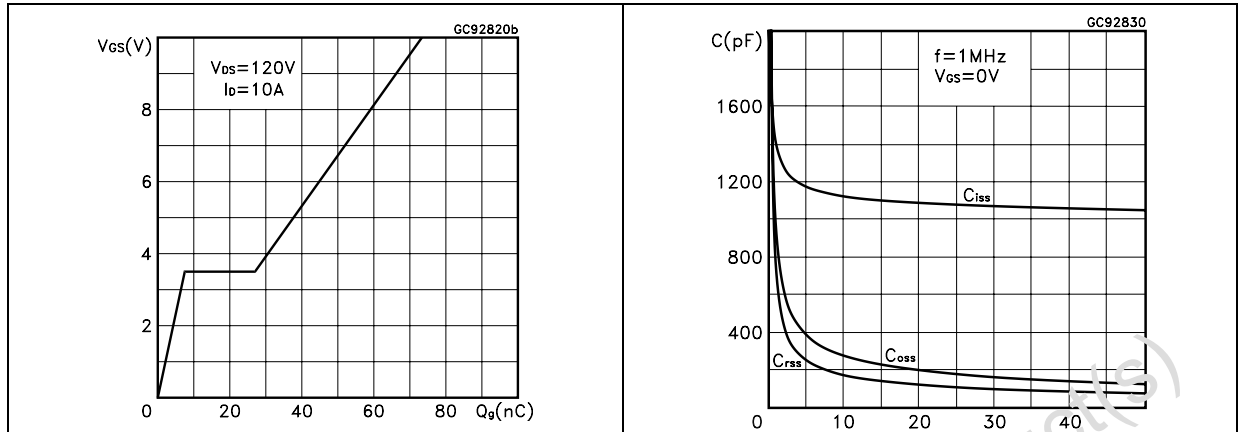


Figure 9. Normalized gate threshold voltage vs temperature Figure 10. Normalized on resistance vs temperature

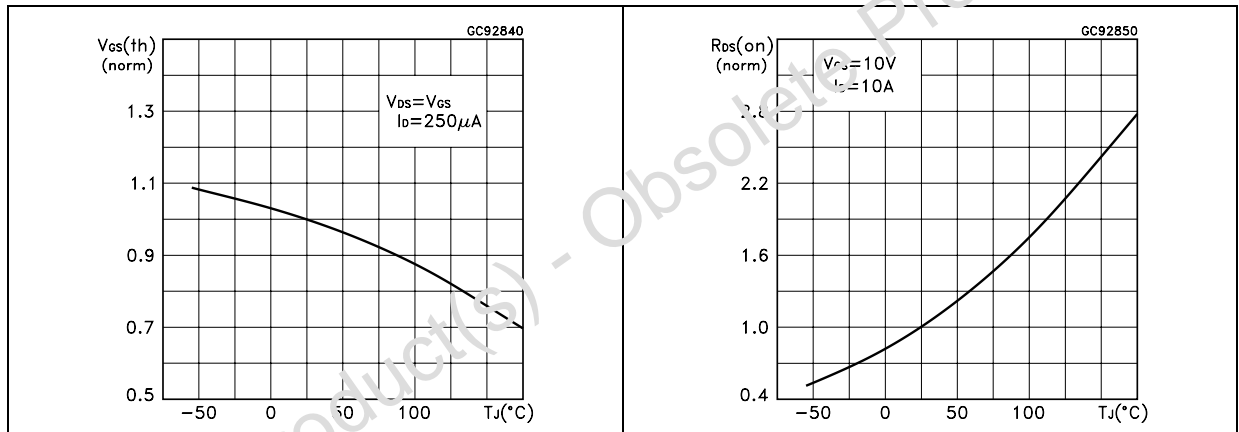
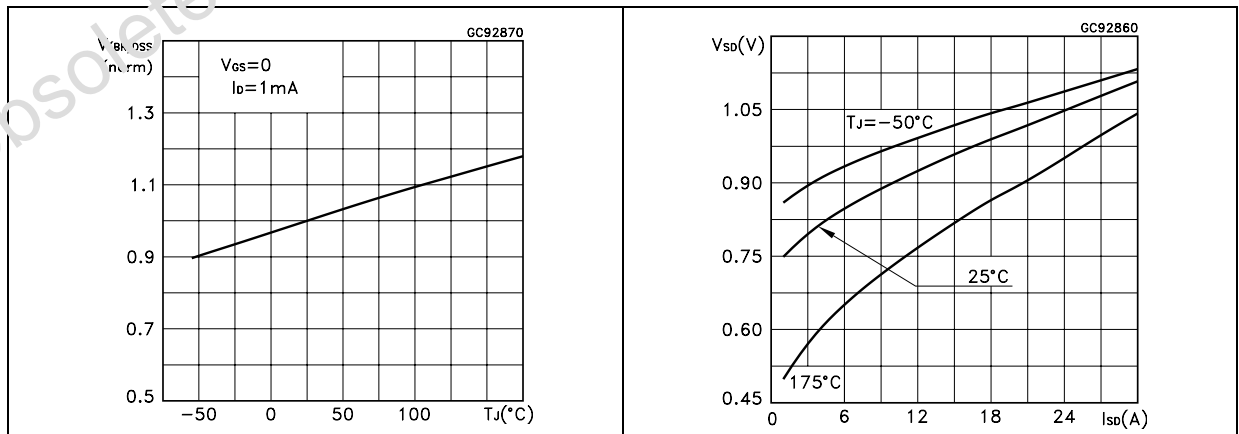


Figure 11. Normalized BV_{DSS} vs temperature Figure 12. Source-drain diode forward characteristics



3 Test circuit

Figure 13. Switching times test circuit for resistive load

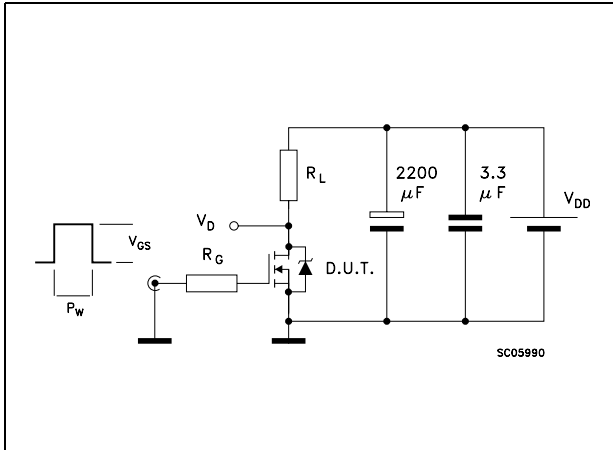


Figure 14. Gate charge test circuit

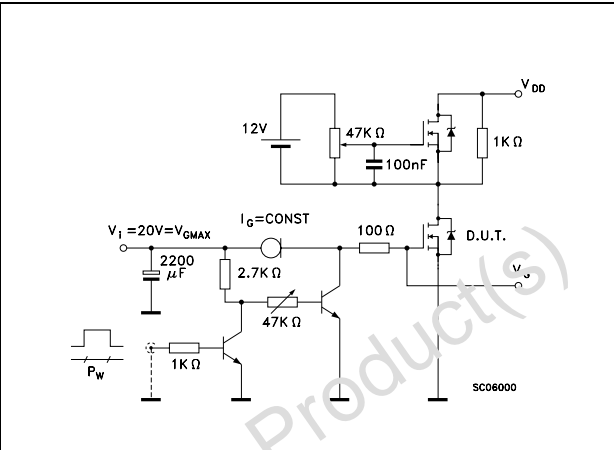


Figure 15. Test circuit for inductive load switching and diode recovery times

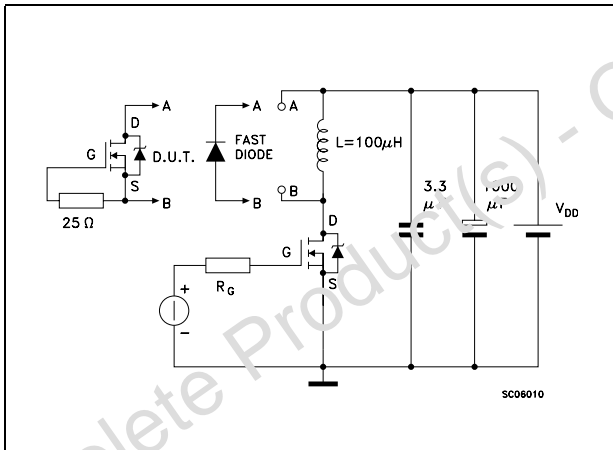


Figure 16. Unclamped Inductive load test circuit

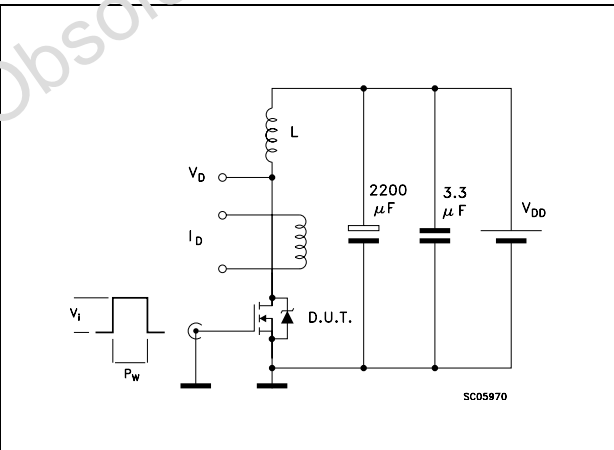


Figure 17. Unclamped inductive waveform

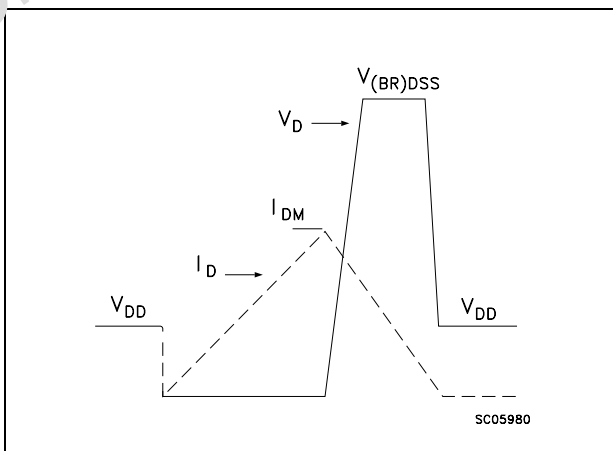
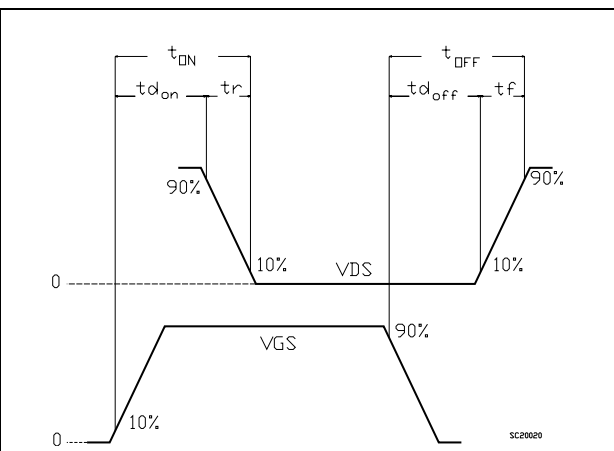


Figure 18. Switching time waveform



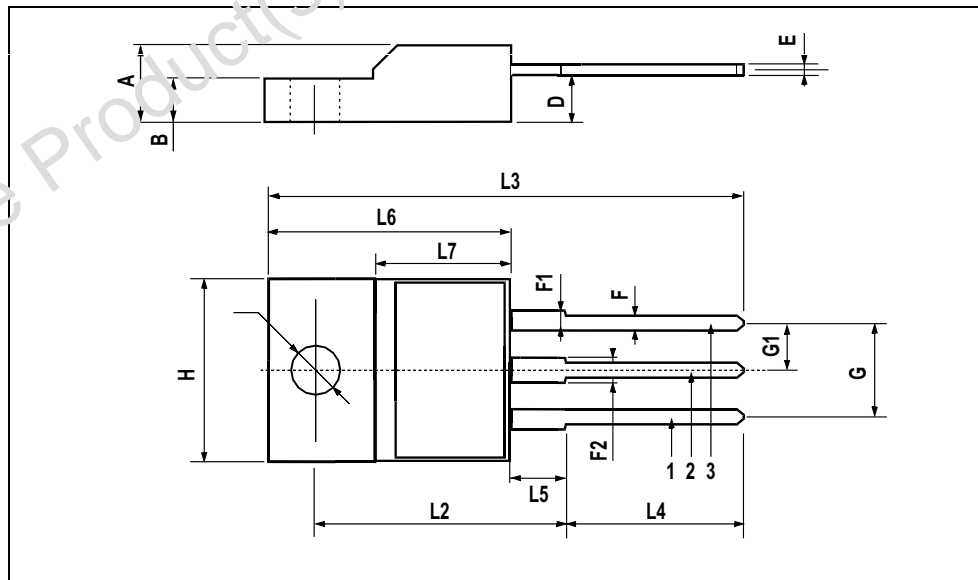
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

Obsolete Product(s) - Obsolete Product(s)

TO-220FP MECHANICAL DATA

| DIM. | mm. | | | inch | | |
|------|------|------|------|-------|-------|-------|
| | MIN. | TYP. | MAX. | MIN. | TYP. | MAX. |
| A | 4.4 | | 4.6 | 0.173 | | 0.181 |
| B | 2.5 | | 2.7 | 0.098 | | 0.106 |
| D | 2.5 | | 2.75 | 0.098 | | 0.108 |
| E | 0.45 | | 0.7 | 0.017 | | 0.027 |
| F | 0.75 | | 1 | 0.030 | | 0.039 |
| F1 | 1.15 | | 1.7 | 0.045 | | 0.067 |
| F2 | 1.15 | | 1.7 | 0.045 | | 0.067 |
| G | 4.95 | | 5.2 | 0.195 | | 0.204 |
| G1 | 2.4 | | 2.7 | 0.094 | | 0.106 |
| H | 10 | | 10.4 | 0.393 | | 0.409 |
| L2 | | 16 | | | 0.630 | |
| L3 | 28.6 | | 30.6 | 1.126 | | 1.204 |
| L4 | 9.8 | | 10.6 | 0.385 | | 0.417 |
| L5 | 2.9 | | 3.6 | 0.114 | | 0.141 |
| L6 | 15.9 | | 16.4 | 0.626 | | 0.645 |
| L7 | 9 | | 9.3 | 0.354 | | 0.366 |
| Ø | 3 | | 3.2 | 0.118 | | 0.126 |



5 Revision history

Table 6. Revision history

| Date | Revision | Changes |
|-------------|-----------------|---------------------------------|
| 09-Sep-2004 | 2 | Complete document |
| 16-Aug-2006 | 3 | New template, no content change |

Obsolete Product(s) - Obsolete Product(s)

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